

PERRY JOHNSON LABORATORY ACCREDITATION, INC.

Certificate of Accreditation

Perry Johnson Laboratory Accreditation, Inc. has assessed the Laboratory of:

Calibración Especializada Industrial / Saul Felipe Rodríguez Guzmán M.M De Llano #915-A, Col. Centro Monterrey, Nuevo León, México. C.P. 64000

(Hereinafter called the Organization) and hereby declares that Organization is accredited in accordance with the recognized International Standard:

ISO/IEC 17025:2017

This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (as outlined by the joint ISO-ILAC-IAF Communiqué dated April 2017):

Electrical, Mass, Force and Weighing Devices, Time and Frequency,

Thermodynamic and Dimensional Calibration

(As detailed in the supplement)

Accreditation claims for such testing and/or calibration services shall only be made from addresses referenced within this certificate. This Accreditation is granted subject to the system rules governing the Accreditation referred to above, and the Organization hereby covenants with the Accreditation body's duty to observe and comply with the said rules.

For PJLA:

Initial Accreditation Date:

Issue Date:

Expiration Date:

June 02, 2018

August 02, 2024

October 31, 2026

Accreditation No.:

Certificate No.:

91241

L24-582

Tracy Szerszen President

Perry Johnson Laboratory Accreditation, Inc. (PJLA) 755 W. Big Beaver, Suite 1325 Troy, Michigan 48084

The validity of this certificate is maintained through ongoing assessments based on a continuous accreditation cycle. The validity of this certificate should be confirmed through the PJLA website: www.pjlabs.com

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M.M De Llano #915-A, Col. Centro Monterrey, Nuevo León, México. C.P. 64000 Contact Name: Saúl F. Rodríguez Phone: 818-647-0493

Accreditation is granted to the facility to perform the following calibrations:

MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE (AND SPECIFICATION WHERE APPROPRIATE)	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED	CALIBRATION MEASUREMENT METHOD OR PROCEDURES USED
Equipment to Measure	1 mV to 329.999 9 mV	0.005 7 % of reading	Fluke 5502A	Procedure I-02
DC Voltage ^{FO}	330 mV to 3.299 999 V	0.004 4 % of reading	Fluke 725	
	3.3 V to 32.999 99 V	0.004 % of reading		
	33 V to 329.999 9 V	0.004 7 % of reading		
	330 V to 1 020 V	0.005 % of reading		
Equipment to Output	1 mV to 200 mV	0.000 66 % of reading	Fluke 8508A	Procedure I-10
DC Voltage ^{FO}	200 mV to 2 V	0.000 34 % of reading		
	2 V to 20 V	0.000 34 % of reading		
	20 V to 200 V	0.000 49 % of reading		
	200 V to 1000 V	0.000 53 % of reading		
Equipment to Output	1 kV to 40 kV	1.2 % of reading	Fluke 80K-40 &	Procedure I-01
and Measure AC/DC High Voltage ^{FO}	20 kV to 200 kV	1.2 % of reading	Fluke 8060A Phenix KVM 200	
Equipment to Measure	1 μA to 329.999 μA	0.017 % of reading	Fluke 5502A Fluke 725	Procedure I-02
DC Current ^{FO}	330 μA to 3.299 99 mA	0.015 % of reading		
	3.3 mA to 32.999 9 mA	0.009 % of reading		
	33 mA to 329.999 mA	0.008 9 % of reading		
	330 mA to 1.099 99 A	0.033 % of reading		
	1.1 A to 2.999 99 A	0.031 % of reading		
	3 A to 10.999 9 A	0.052 % of reading	J	
	11 A to 20.5 A	0.092 % of reading		
Clamp-On Meters ^{FO}	Up A to 1 025 A	0.44 % of reading	Fluke 5502A/50 Turn Coil	Procedure I-06, I-07
Equipment to Output	1 μA to 200 μA	0.001 5 % of reading	Fluke 8508A	Procedure I-10
DC Current ^{FO}	200 μA to 2 mA	0.001 5 % of reading		
	2 mA to 20 mA	0.001 5 % of reading		
	20 mA to 200 mA	0.003 8 % of reading		
	200 mA to 2 A	0.017 % of reading	1	
	2 A to 20 A	0.037 % of reading	1	
Equipment to Measure	1 Ω to 10.999 Ω	0.08 % of reading	Fluke 5502A	Procedure I-02
Resistance ^{FO}	11 Ω to 32.999 Ω	0.042 % of reading		



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Equipment to Measure	33 Ω to 109.999 Ω	0.018 % of reading	Fluke 5502A	Procedure I-02
Resistance ^{FO}	110 Ω to 329.999 Ω	0.012 % of reading		
	330 Ω to 1.099 99 kΩ	0.009 9 % of reading		
	1.1 kΩ to 3.299 99 kΩ	0.012 % of reading]	
	3.3 kΩ to 10.999 9 kΩ	0.009 3 % of reading]	
	11 kΩ to 32.999 9 kΩ	0.009 5 % of reading]	
	33 kΩ to 109.999 kΩ	0.011 % of reading]	
	110 k Ω to 329.999 k Ω	0.012 % of reading		
	330 kΩ to 1.099 99 MΩ	0.013 % of reading		
	$1.1~\mathrm{M}\Omega$ to $3.299~99~\mathrm{M}\Omega$	0.015 % of reading		
	$3.3~\mathrm{M}\Omega$ to $10.999~9~\mathrm{M}\Omega$	0.049 % of reading		
	11 MΩ to 32.999 9 MΩ	0.084 % of reading		
	33 MΩ to 109.999 MΩ	0.39 % of reading		
	110 MΩ to 329.999 MΩ	0.41 % of reading		
	330 MΩ to 1 100 MΩ	1.2 % of reading		
Equipment to Measure	1 mΩ	0.014 % of reading	Electromera	Procedure I-08
Resistance	10 mΩ	0.013 % of reading	P310 0.001M, P310	
(Fixed Points) ^{FO}	100 mΩ	0.012 % of reading	01M P321 0.1M, P321 1M	
	1 Ω	0.011 % of reading	P321 10M	
	10 Ω	0.01 % of reading		
	10 Ω to 10 kΩ	0.059 % of reading	Decade Box GenRad	Procedure DE-10,
	1 GΩ	0.072 % of reading	1433-12 Resistor,	Procedure I-02
	$10~\mathrm{M}\Omega$ to $100~\mathrm{M}\Omega$	0.031 % of reading	Katywka P4030-MI Decade Box Katywka	
	100 MΩ to 1 000 MΩ	0.031 % of reading	4077 Decade Box Katywka 4078	
Equipment to Output	$0.001~\Omega$ to $2~\Omega$	0.001 7 % of reading	Fluke 8508A	Procedure I-10
Resistance ^{FO}	2 Ω to 20 Ω	0.001 % of reading]	
	20 Ω to 200 Ω	0.000 79 % of reading	1	
	200 Ω to 2 kΩ	0.000 8 % of reading	1	
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Equipment to Output	$2 \text{ k}\Omega$ to $20 \text{ k}\Omega$	0.000 81 % of reading	Fluke 8508A	Procedure I-10
Resistance ^{FO}	$20~\text{k}\Omega$ to $200~\text{k}\Omega$	0.000 81 % of reading		
	$200~\text{k}\Omega$ to $2~\text{M}\Omega$	0.001 % of reading		
	$2 \text{ M}\Omega$ to $20 \text{ M}\Omega$	0.002 8 % of reading		
	$20~\mathrm{M}\Omega$ to $200~\mathrm{M}\Omega$	0.007 8 % of reading		
	$200~\mathrm{M}\Omega$ to $2~\mathrm{G}\Omega$	0.1 % of reading		
	$2 G\Omega$ to $20 G\Omega$	0.1 % of reading		
Equipment to Measure AC Voltage At the listed Frequencies ^{FO}			Fluke 5502A	Procedure I-02
10 Hz to 45 Hz	1 mV to 32.999 mV	0.16 % of reading		
45 Hz to 10 kHz	1 mV to 32.999 mV	0.13 % of reading		
10 kHz to 20 kHz	1 mV to 32.999 mV	0.16 % of reading		
20 kHz to 50 kHz	1 mV to 32.999 mV	0.2 % of reading		
50 kHz to 100 kHz	1 mV to 32.999 mV	0.35 % of reading		
100 kHz to 500 kHz	1 mV to 32.999 mV	0.92 % of reading		
Equipment to Measure AC Voltage At the listed Frequencies ^{FO}				
10 Hz to 45 Hz	33 mV to 329.999 mV	0.045 % of reading		
45 Hz to 10 kHz	33 mV to 329.999 mV	0.029 % of reading		
10 kHz to 20 kHz	33 mV to 329.999 mV	0.059 % of reading		
20 kHz to 50 kHz	33 mV to 329.999 mV	0.087 % of reading		
50 kHz to 100 kHz	33 mV to 329.999 mV	0.22 % of reading		
100 kHz to 500 kHz	33 mV to 329.999 mV	0.49 % of reading		
Equipment to Measure AC Voltage				
At the listed Frequencies ^{FO} 10 Hz to 45 Hz	0.33 V to 3.299 99 V	0.042 % of reading	-	
45 Hz to 10 kHz	0.33 V to 3.299 99 V	0.027 % of reading	-	
10 kHz to 20 kHz	0.33 V to 3.299 99 V	0.056 % of reading	-	
20 kHz to 50 kHz	0.33 V to 3.299 99 V	0.079 % of reading	-	
50 kHz to 100 kHz	0.33 V to 3.299 99 V	0.18 % of reading	-	
100 kHz to 500 kHz	0.33 V to 3.299 99 V	0.41 % of reading	1	



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Electrical

Issue: 08/2024

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Equipment to Measure			Fluke 5502A	Procedure I-02
AC Voltage				
At the listed Frequencies ^{FO} 10 Hz to 45 Hz	3.3 V to 32.999 9 V	0.042 % of reading		
		_		
45 Hz to 10 kHz	3.3 V to 32.999 9 V	0.029 % of reading		
10 kHz to 20 kHz	3.3 V to 32.999 9 V	0.056 % of reading		
20 kHz to 50 kHz	3.3 V to 32.999 9 V	0.079 % of reading		
50 kHz to 100 kHz	3.3 V to 32.999 9 V	0.18 % of reading		
Equipment to Measure AC Voltage At the listed Frequencies ^{FO}				
45 Hz to 1 kHz	33 V to 329.999 V	0.04 % of reading		
1 kHz to 10 kHz	33 V to 329.999 V	0.064 % of reading		
10 kHz to 20 kHz	33 V to 329.999 V	0.072 % of reading		
20 kHz to 50 kHz	33 V to 329.999 V	0.096 % of reading		
50 kHz to 100 kHz	33 V to 329.999 V	0.21 % of reading		
Equipment to Measure AC Voltage At the listed Frequencies ^{FO}		193	-0	
45 Hz to 1 kHz	330 V to 1 020 V	0.041 % of reading		
1 kHz to 5 kHz	330 V to 1 020 V	0.064 % of reading		
5 kHz to 10 kHz	330 V to 1 020 V	0.072 % of reading		
Equipment to Output	1 mV to 200 mV	0.011 % of reading	Fluke 8508A	Procedure I-10
AC Voltage	200 mV to 2 V	0.006 9 % of reading		
At the listed Frequencies 10 Hz to 100 kHz ^{FO}	2 V to 20 V	0.007 1 % of reading		
10 112 to 100 kHz	20 V to 200 V	0.007 2 % of reading		
	200 V to 1000 V	0.011 % of reading		
Equipment to Output	0.75 kV to 20 kV	1.2 % of reading	Phoenix KVM 200	Procedure I-01
and Measure AC Voltage ^{FO} At the listed Frequencies Up to 1 000 Hz	20 kV to 200 kV	1.2 % of reading		
Equipment to Output and Measure AC Voltage ^{FO} At the listed Frequencies Up to 3 kHz	2 kV to 8.5 kV	2.1 % of reading	Tektronix P6013A / Fluke 87V	Procedure I-09



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Equipment to Measure AC Current		, ,	Fluke 5502A	Procedure I-02
At the listed Frequencies ^{FO}	T	1		
10 Hz to 20 Hz	29 μA to 329.99 μA	0.18 % of reading		
20 Hz to 45 Hz	29 μA to 329.99 μA	0.14 % of reading		
45 Hz to 1 kHz	29 μA to 329.99 μA	0.12 % of reading		
1 kHz to 5 kHz	29 μA to 329.99 μA	0.27 % of reading		
5 kHz to 10 kHz	29 μA to 329.99 μA	0.67 % of reading		
10 kHz to 30 kHz	29 μA to 329.99 μA	1.3 % of reading		
Equipment to Measure AC Current At the listed Frequencies ^{FO}		70	7	
10 Hz to 20 Hz	0.33 mA to 3.299 99 mA	0.16 % of reading	/	
20 Hz to 45 Hz	0.33 mA to 3.299 99 mA	0.1 % of reading		
45 Hz to 1 kHz	0.33 mA to 3.299 99 mA	0.081 % of reading		
1 kHz to 5 kHz	0.33 mA to 3.299 99 mA	0.16 % of reading		
5 kHz to 10 kHz	0.33 mA to 3.299 99 mA	0.39 % of reading	-0	
10 kHz to 30 kHz	0.33 mA to 3.299 99 mA	0.79 % of reading		
Equipment to Measure AC Current At the listed Frequencies ^{FO}		CO		
10 Hz to 20 Hz	3.3 mA to 32.999 9 mA	0.15 % of reading		
20 Hz to 45 Hz	3.3 mA to 32.999 9 mA	0.075 % of reading		
45 Hz to 1 kHz	3.3 mA to 32.999 9 mA	0.04 % of reading		
1 kHz to 5 kHz	3.3 mA to 32.999 9 mA	0.073 % of reading		
5 kHz to 10 kHz	3.3 mA to 32.999 9 mA	0.16 % of reading		
10 kHz to 30 kHz	3.3 mA to 32.999 9 mA	0.32 % of reading		
Equipment to Measure AC Current At the listed Frequencies ^{FO}				
10 Hz to 20 Hz	33 mA to 329.999 mA	0.14 % of reading		
20 Hz to 45 Hz	33 mA to 329.999 mA	0.075 % of reading		
45 Hz to 1 kHz	33 mA to 329.999 mA	0.037 % of reading		





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Equipment to Measure			Fluke 5502A	Procedure I-02
AC Current				
At the listed Frequencies ^{FO}				
1 kHz to 5 kHz	33 mA to 329.999 mA	0.09 % of reading		
5 kHz to 10 kHz	33 mA to 329.999 mA	0.18 % of reading		
10 kHz to 30 kHz	33 mA to 329.999 mA	0.36 % of reading		
Equipment to Measure AC Current At the listed Frequencies ^{FO}				
10 Hz to 45 Hz	0.33 A to 1.099 99 A	0.15 % of reading		
45 Hz to 1 kHz	0.33 A to 1.099 99 A	0.048 % of reading		
1 kHz to 5 kHz	0.33 A to 1.099 99 A	0.54 % of reading		
5 kHz to 10 kHz	0.33 A to 1.099 99 A	2.3 % of reading		
Equipment to Measure AC Current At the listed Frequencies ^{FO}			X	
10 Hz to 45 Hz	1.1 A to 2.999 99 A	0.14 % of reading		
45 Hz to 1 kHz	1.1 A to 2.999 99 A	0.05 % of reading		
1 kHz to 5 kHz	1.1 A to 2.999 99 A	0.49 % of reading	\	
5 kHz to 10 kHz	1.1 A to 2.999 99 A	2.1 % of reading		
Equipment to Measure AC Current At the listed Frequencies ^{FO}				
10 Hz to 100 Hz	3 A to 10.999 9 A	0.063 % of reading		
1 kHz to 5 kHz	3 A to 10.999 9 A	2.4 % of reading		
100 Hz to 1 kHz	3 A to 10.999 9 A	0.093 % of reading		
Equipment to Measure AC Current At the listed Frequencies ^{FO}				
10 Hz to 100 Hz	11 A to 20.5 A	0.11 % of reading		
100 Hz to 1 kHz	11 A to 20.5 A	0.14 % of reading		
1 kHz to 5 kHz	11 A to 20.5 A	2.4 % of reading	1	



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Equipment to Measure AC Current At the listed Frequencies ^{FO} Clamps-On Meter			Fluke 5502A/50 Turn Coil	Procedure I-06
45 Hz to 65 Hz	Up to 1 025 A	0.52 % of reading		
Equipment to Output	1 μA to 200 μA	0.068 % of reading	Fluke 8508A	Procedure I-10
AC Current 10 Hz to 10 kHz ^{FO}	200 μA to 2 mA	0.037 % of reading		
10 HZ to 10 kHZ ⁻³	2 mA to 20 mA	0.036 % of reading		
	20 mA to 200 mA	0.033 % of reading		
	200 mA to 2 A	0.064 % of reading		
	2 A to 20 A	0.08 % of reading		
Equipment to Measure	220 pF to 399.9 pF	2.3 % of reading	Fluke 5502A	Procedure I-03
Capacitance @ 1 kHz ^{FO}	0.4 nF to 1.099 9 nF	1.2 % of reading		
	1.1 nF to 3.299 9 nF	0.66 % of reading		
	3.3 nF to 10.999 nF	0.28 % of reading		
	11 nF to 32.999 nF	0.47 % of reading		
	33 nF to 109.99 nF	0.21 % of reading	-0	
	110 nF to 329.99 nF	0.33 % of reading		
	0.33 uF to 1.099 9 uF	0.28 % of reading		
	1.1 uF to 3.299 9 uF	0.33 % of reading		
	3.3 uF to 10.999 uF	0.28 % of reading		
	11 uF to 32.999 uF	0.43 % of reading		
4	33 uF to 109.99 uF	0.45 % of reading		
	110 uF to 329.99 uF	0.46 % of reading		
	0.33 mF to 1.099 9 mF	0.35 % of reading		
	1.1 mF to 3.299 9 mF	0.46 % of reading		
Equipment to Measure	3.3 mF to 10.999 mF	0.42 % of reading		
Capacitance ^{FO}	11 mF to 32.999 mF	0.68 % of reading		
At the listed Frequency	33 mF to 110 mF	0.93 % of reading		
@ 1 kHz Equipment to Output Capacitance ^{FO} At the listed Frequency 20 Hz to 300 kHz	300 pF to 110 mF	0.05 % of reading	Agilent E4980A	Procedure EL-026



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Equipment to Measure AC Power (f = 45 Hz to 60 Hz; P.F.= 3.3 V to 1 020 V At the listed Ampere ^{FO}	1)		Fluke 5502A	Procedure I-07
330 mA to 1.099 9 A	1.089 W to 1.12 kW	0.12 % of reading		
1.1 A to 2.999 A	3.63 W to 3.06 kW	0.11 % of reading		
3 A to 10.999 A	9.9 W to 11.22 kW	0.12 % of reading		
11 A to 20.5 A	36.3 W to 20.91 kW	0.15 % of reading		
20.5 A to 1 025 A	67.7 W to 1 MW (No Toroidal)	0.54 % of reading	Fluke 5502A/50 Turn Coil	
Equipment to Measure Phase or Power Factor (f = 10 Hz to 65 Hz) 120 V to 240 V At the listed Ampere ^{FO}		3	Fluke 5502A	Procedure I-02
2 A to 20 A	-180° to 180°	0.12°		
Equipment to Output At the listed frequencies at the listed Voltage 10 mV to 1000 VFO	10 Hz to 1 MHz	0.005 9 % of reading	Fluke 8508A	Procedure I-10
Temperature Calibration,	250 °C to -100 °C	0.39 °C	Fluke 5502A, Fluke 725	Procedure I-04
Indication and Control	-100 °C to -25 °C	0.14 °C	Electrical Simulation of	
Equipment used with Thermocouple	-25 °C to 350 °C	0.13 °C	Thermocouple Output	
Type E ^{FO}	350 °C to 650 °C	0.14 °C		
	650 °C to 1 000 °C	0.18 °C		
Temperature Calibration,	-210 °C to -100 °C	0.22 °C		
Indication and Control Equipment used with	-100 °C to -30 °C	0.14 °C		
Thermocouple	-30 °C to 150 °C	0.13 °C		
Type J ^{FO}	150 °C to 760 °C	0.15 °C		
	760 °C to 1 200 °C	0.19 °C		
Temperature Calibration,	-200 °C to -100 °C	0.27 °C		
Indication and Control Equipment used with	-100 °C to -25 °C	0.16 °C		
Thermocouple	-25 °C to 120 °C	0.14 °C		
Type K ^{FO}	120 °C to 1 000 °C	0.21 °C		



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Temperature Calibration, Indication and Control Equipment used with Thermocouple Type K ^{FO}	1 000 °C to 1 372 °C	0.32 °C	Fluke 5502A, Fluke 725 Electrical Simulation of Thermocouple Output	Procedure I-04
Temperature Calibration,	250 °C to -150 °C	0.49 °C		
Indication and Control Equipment used with	-150 °C to 0 °C	0.2 °C		
Thermocouple	0 °C to 120 °C	0.14 °C		
Type T ^{FO}	120 °C to 400 °C	0.13 °C		
Temperature Calibration, Indication and Control Equipment used with RTD ^{FO}	-200 °C to 800 °C	0.079 °C	Fluke 8508A Electrical Simulation of RTD Output	
Temperature Calibration,	-200 °C to -80 °C	0.07 °C	Fluke 5502A, Fluke 725	
Indication and Control Equipment used with	-80 °C to 0 °C	0.07 °C	Electrical Simulation of RTD Output	
RTD Pt 385, $100 \Omega^{FO}$	0 °C to 100 °C	0.079 °C		
	100 °C to 300 °C	0.09 °C		
	300 °C to 400 °C	0.097 °C	-0	
	400 °C to 630 °C	0.11 °C		
	630 °C to 800 °C	0.19 °C		
Temperature Calibration,	-200 °C to -80 °C	0.07 °C		
Indication and Control Equipment used with RTD Pt 3926, $100 \Omega^{FO}$	-80 °C to 0 °C	0.07 °C		
Temperature Calibration,	0 °C to 100 °C	0.08 °C	Fluke 5502A, Fluke 725	1
Indication and Control	100 °C to 300 °C	0.091 °C	Electrical Simulation of	
Equipment used with RTD Pt 3926, $100 \Omega^{FO}$	300 °C to 400 °C	0.097 °C	- RTD Output	
100 100 20, 100 22	400 °C to 630 °C	0.11 °C		
Temperature Calibration,	-200 °C to -190 °C	0.066 °C		
Indication and Control	-190 °C to -80 °C	0.066 °C		
Equipment used with RTD Pt 3916, $100 \Omega^{FO}$	-80 °C to 0 °C	0.07 °C		
,	0 °C to 100 °C	0.074 °C		
	100 °C to 260 °C	0.079 °C		
	260 °C to 300 °C	0.085 °C		





Calibración Especializada Industrial / Saul Felipe Rodríguez Guzmán

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Accreditation is granted to the facility to perform the following calibrations:

Electrical

MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE (AND SPECIFICATION WHERE APPROPRIATE)	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED	CALIBRATION MEASUREMENT METHOD OR PROCEDURES USED
Temperature Calibration,	300 °C to 400 °C	0.091 °C	Fluke 5502A,	Procedure I-04
Indication and Control	400 °C to 600 °C	0.097 °C	Fluke 725 Electrical Simulation of	
Equipment used with RTD Pt 3916, $100 \Omega^{FO}$	600 °C to 630 °C	0.19 °C	RTD Output	
Equipment to Output AC Current ^{FO} At the listed Frequencies 15 Hz to 1 kHz	20 A to 1 400 A	1.9 % of reading	Fluke 345	Procedure EL-027
Equipment to Output DC Current FO	20 A to 2 000 A	1.9 % of reading		
Equipment to Output or Measure ^{FO} AC High Voltage At the listed Frequencies (Up to 3 kHz)	2 kV to 15 kV	2.8 % of reading	HyPot Multimeter Brand: CEI Model: ML-HF-1	Procedure I-09

Mass, Force and Weighting Devices

MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE (AND SPECIFICATION WHERE APPROPRIATE)	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED	CALIBRATION MEASUREMENT METHOD OR PROCEDURES USED
Balance and Scale ^O	1 mg to 1 000 g (Res.= 0.1 mg) 1 kg to 10 kg (Res.= 0.1 g)	0.45 mg 0.083 g	Class F1 Test Weights	Procedure DE-13 Euramet CG-18

Time and Frequency

MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE (AND SPECIFICATION WHERE APPROPRIATE)	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED	CALIBRATION MEASUREMENT METHOD OR PROCEDURES USED
Stopwatch Timer ^{FO}	Up to 10 800 s	0.001 1 % of reading	Fluke 5502A and Digital Counter, Stopwatch and Timer Calibrations	Procedure DE-08 NIST 960-12 Practice Guide
Equipment to Measure Frequency at the listed Voltage	0.01 Hz to 119.99 Hz 120 Hz to 1 199.9 Hz	0.002 9 % of reading 0.005 2 % of reading	Fluke 5502A Fluke 725	Procedure I-02
100 mV to 750 V ^{FO}	12 kHz to 119.99 kHz	0.005 2 % of reading		





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Accreditation is granted to the facility to perform the following calibrations:

Thermodynamic

Thermodynamic						
MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE (AND SPECIFICATION WHERE APPROPRIATE)	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED	CALIBRATION MEASUREMENT METHOD OR PROCEDURES USED		
Digital Infrared Thermometer ^{FO}	-15 °C to 120 °C	0.61 °C	Fluke 4180 & Fluke 4181 Precision Infrared Calibrator (Black Body Source)	Procedure DE-09		
	50 °C to 500 °C	0.66 °C	Fluke 4181 Precision Infrared Calibrator (Black Body Source)			
Thermo-Hygrometer Only Humidity ^F	20 % RH to 90 % RH	1.3 % RH	Hygro-Thermometer Brand Vaisala	CENAM Technical Guide		
Thermo-Hygrometer Only Temperature ^F	20 °C to 70 °C	0.2 °C	CEM DE-11			
Direct Reading Thermometer ^{FO}	0 °C (Cold Joint Point) 35 °C to 375 °C	0.031 °C 0.11 °C	RTD KAYE Model M2801 Dry Well Fluke 9100S	Procedure DE-14 CEM TH001		

Dimensional

MEASURED	RANGE	CALIBRATION	CALIBRATION	CALIBRATION
INSTRUMENT,	(AND SPECIFICATION	AND MEASUREMENT	EQUIPMENT AND	MEASUREMENT
QUANTITY OR GAUGE	WHERE APPROPRIATE)	CAPABILITY EXPRESSED	REFERENCE	METHOD OR
		AS AN UNCERTAINTY (±)	STANDARDS USED	PROCEDURES USED
Outside Micrometers ^{FO}	0.105 in to 12 in	29 μin	Grade 0 Gage Blocks	Procedure DE-07
Caliper ^{FO}	0.105 in to 12 in	290 μίη		CENAM Technical
Camper	0.105 III to 12 III	250 pm		Guide

- 1. The CMC (Calibration and Measurement Capability) stated for calibrations included on this scope of accreditation represents the smallest measurement uncertainty attainable by the laboratory when performing a more or less routine calibration of a nearly ideal device under nearly ideal conditions. It is typically expressed at a confidence level of 95 % using a coverage factor k (usually equal to 2). The actual measurement uncertainty associated with a specific calibration performed by the laboratory will typically be larger than the CMC for the same calibration since capability and performance of the device being calibrated and the conditions related to the calibration may reasonably be expected to deviate from ideal to some degree.
- 2. The laboratories range of calibration capability for all disciplines for which they are accredited is the interval from the smallest calibrated standard to the largest calibrated standard used in performing the calibration. The low end of this range must be an attainable value for which the laboratory has or has access to the standard referenced. Verification of an indicated value of zero in the absence of a standard is common practice in the procedure for many calibrations but by its definition it does not constitute calibration of zero capacity.

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Certificate of Accreditation: Supplement

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Accreditation is granted to the facility to perform the following calibrations:

- 3. The presence of a superscript F means that the laboratory performs calibration of the indicated parameter at its fixed location.
- 4. The presence of a superscript O means that the laboratory performs calibration of the indicated parameter onsite at customer locations.
- 5. Measurement uncertainties obtained for calibrations performed at customer sites can be expected to be larger than the measurement uncertainties obtained at the laboratories fixed location for similar calibrations. This is due to the effects of transportation of the standards and equipment and upon environmental conditions at the customer site which are typically not controlled as closely as at the laboratories fixed location.

